Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S1	5	(("5783340") or ("5798283") or ("5804084") or ("5867302") or ("6082208")).PN.	US-PGPUB; USPAT; EPO; JPO; IBM_TDB	OR	OFF	2005/10/06 13:23
S2	0	Particle adj fiter	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/04 11:27
S3	8243	Particle adj filter	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/05 13:20
S4	4442	S3 and method	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/05 12:39
S5	72	S3 and mems	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/04 11:53
S6	3649	S4 and (@ad<"20020820" or @rlad<"20020820")	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/04 11:31
S7	38	S5 and (@ad<"20020820" or @rlad<"20020820")	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/04 11:31
S8	8243	Particle adj filter	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/04 11:53
S9	72	S8 and mems	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/04 11:53
S10	38	S9 and (@ad<"20020820" or @rlad<"20020820")	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/04 11:53

S11	34	S9 not S10	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/04 11:54
S12	7	("4690750" | "5882496" | "5938923" | "6110247" | "6120573" | "6187412" | "6524488").PN. OR ("6875257").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/10/04 12:34
S13	8	("5107328" | "5435876" | "5605489" | "5872046" | "5923995" | "6012336" | "6063696" | "6335224").PN. OR ("6703675"). URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/10/04 12:38
S14	14	("20010048265" | "5107328" | "5435876" | "5605489" | "5610431" | "5798283" | "5872046" | "5923995" | "5986381" | "6063696" | "6082208" | "6133670" | "6175170" | "6335224").PN. OR ("6700173").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/10/04 12:40
S15	267	(210/438).CCLS.	US-PGPUB; USPAT; EPO; JPO; IBM_TDB	OR	OFF	2005/10/05 13:14
S16	8243	Particle adj filter	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/05 13:20
S17	1001	S16 and substrate	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/05 13:20
S18	8784	((438/689,200,745,748) or (216/11, 13,41,56) or (428/641) or (427/58)).CCLS.	US-PGPUB; USPAT; EPO; JPO; IBM_TDB	OR	OFF	2005/10/07 10:36
S19	892	S18 and filter	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/06 13:25
S20	1018	(438/700).CCLS.	US-PGPUB; USPAT; EPO; JPO; IBM_TDB	OR	OFF	2005/10/07 10:36

S21	29	S20 and filter	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/07 10:52
S22	35	S20 and mems	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/07 11:01
S23	2831	(mems or (microelectromechanical adj system) or (micromechanical adj system) or (micro adj electro adj mechanical adj system) or (micro adj mechanical adj system)) same filter	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/07 11:04
S24	781	S23 and particle	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/07 11:09
S25	38	S23 and (particle adj filter)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/07 11:05
S26	0	("2002/0134752").URPN.	USPAT	OR	ON	2005/10/11 10:50
S27	1425268	filter	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/11 11:00
S28	837123	noise	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/11 11:00
S29	1201743	S27 not S28	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/11 11:01
S30	46685	S29 and etch$3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/11 11:01
S31	4539	S30 and particle and contamination	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/11 11:02

S32	4033	S31 and (semiconductor or substrate)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/11 11:04
S33	284	S32 and mems	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/10/11 11:04